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80% based on micro treatment of silicon, according this mastered technologies of framework on the wafer and 3D-assemblage.
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Tarnavsky G. A. On the Way to Nanoelectronics: Possible Growth Points
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Belyanin A. F., Samoylovich M. I., Krivchenko V. A., Paschenko P. V., Suetin N. V., Timofeev M. A. <i>Nano-Structured ZnO Films in Mirrors and UV-Emission Sensors</i>
Belous A. I., Emelyanov V. A., Drozd S. E., Konnov E. V., Mukhurov N. I., Plebanovich V. A. VLIC Schematic Design of
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Sources
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Sighov A. S., Verbitskiy S. S., Emohonov V. N., Shilyaev A. A. On the Problem of the Perspective (Maximum) Characteristics
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The new combination of physical principles of energy absorption of radiation and its subsequent dispersion in the detector was offered. Keywords: thermal detector, maximum detectability, high speed of response, width range of lengths of waves.

Vavilov V. D., Glazkov O. N. The MEMS-Accelerometer Stochastic Error Reseaech
The object of this article is to research stochastic process effect, for example, white noise, on bias and scale factor of MEMS-
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search.
Keywords: acceleration, stochastic, error, model, signal, parasitic signal, bandwidth, transfer function, MEMS, accelerometer,
mean-square error, broad band, white noise, bias, spectral, intensity.

Keywords: direct nuclear-electrical energy convertion, secondary electrons, hybrid current sources, super-capacitors, multi-layer emitter — isolator — collector structures.

In the work a probability of application of natural geyserites and synthetic opal matrices for systems cultivation cellular, including mesenchymal cells, is shown. The features of growth and structure of systems "opal matrice (geyserite) — mesenchymal cell" are considered. It is revealed, that natural geyserites, consisted of amorphous opal and characterized the disordered structure with system of pores of nano- and microsizes, possess ability to execute the functions of skeleton — matrix for implanted cellular cultures as compared to synthetic opals — three-dimensional nanostructures based on cubic packing of ${\rm SiO}_2$ nanospheres.

Keywords: opal matrixes, geyserite, mesenchymal cells, nanostructures.

The new approach for detection of proteins and DNA based on the electrodes, shielded by thin liquid organic film is proposed. The possibility for electrochemical registration of proteins due to their extraction into organic media is shown. The effect is useful for analytical proteins determination. Using shielded electrodes the new method of label-free electrochemical registration of DNA was elaborated. The new approach possesses a high sensitivity enough to distinguish the single mismatch oligonucleotide from complement.

Keywords: electroanalysis, protein electroactivity, interface between immiscible liquids, protein extraction, dna sensor.

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